Search Notes			

Application No.	Applicant(s)	
10/806,980	CHEUNG ET AL.	
Examiner	, Art Unit	
Almis R Jankus	2671	

	SEARCHED			
Class	Subclass	Date	Examiner	
345	424 473 474	9/30/04	3	
	171			
·				

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		i	

(INCLUDING SEAR)	DATE	EXMR
See attached seen IEEE	930/04	3
	-	